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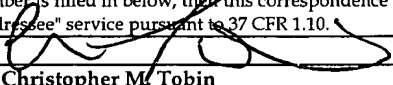
IN THE  
UNITED STATES PATENT AND TRADEMARK OFFICE

APPLICANTS: David Alumot, Gad Neumann,  
Rivka Sherman & Ehud Tirosh

PRIOR APPLICATION:

SERIAL NO.: 07/790,871  
FILING DATE: November 12, 1991  
TITLE: TWO-PHASE OPTICAL INSPECTION METHOD AND APPARATUS  
FOR DEFECT DETECTION  
EXAMINER: A. Johns  
GROUP ART UNIT: 2606  
OLD ATTY. DKT. NO.: 2822US

NEW ATTY. DKT. NO.: 3154US

CERTIFICATE OF MAILING			
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BOX PATENT APPLICATION  
ASSISTANT COMMISSIONER FOR PATENTS  
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PRELIMINARY AMENDMENT

Kindly enter the following amendments in the above-referenced case.

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